

Notice of References Cited			Application/Control No. 10/591,471	Applicant(s)/Patent Under Reexamination FURUYA ET AL.	
Examiner <i>QPM M07</i> Quyen P. Leung			Art Unit 2874	Page 1 of 1	

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	L	US-			
	M	US-			

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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